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|-----------------------------------|--|-------------------------|---|--|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination | |
| | | 10/609,179 | MOBLEY ET AL. | |
| Examiner | | Art Unit | Cachet I. Sellman | |
| | | 1762 | Page 1 of 1 | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------------|----------------|
| * | A | US-6,649,273 B2 | 11-2003 | Iwato et al. | 428/448 |
| * | B | US-2004/0253370 A1 | 12-2004 | Hoersch, Werner | 427/175 |
| * | C | US-3,169,885 | 02-1965 | GOLODNER MARCOS M; et. al. | 427/245 |
| * | D | US-3,772,059 | 11-1973 | Shikada, Tatsunori | 427/246 |
| * | E | US-2004/0109992 A1 | 06-2004 | Gribble et al. | 428/315.9 |
| * | F | US-4,833,173 | 05-1989 | Spek et al. | 521/72 |
| * | G | US-5,859,111 | 01-1999 | Kukkala et al. | 524/458 |
| * | H | US-3,598,780 | 08-1971 | ShKapenko et al. | 524/391 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages |
|---|---|--|
| | U | |
| | V | |
| | W | |
| | X | |

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